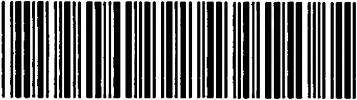


<b>Search Notes</b>  	<b>Application/Control No.</b>  10681103	<b>Applicant(s)/Patent Under Reexamination</b>  FEI ET AL.
	<b>Examiner</b>  PAK, JOHN	<b>Art Unit</b>  1616

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STN Online, Files HCAPLUS, WPIDS, MEDLINE. See printout	5/07	JP
Inventor names searched	5/07	JP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner